

Notice of References Cited	Application/Control No. 10/728,304	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Tung X. Nguyen	Art Unit 2829	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,577,490	06-2003	Ogawa et al.	361/306.1
	B	US-6,756,663	06-2004	Shiraishi et al.	257/686
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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